Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

10603055

BLASI ET AL.

Examiner

Jacob, Mary C

Art Unit 2123

Notes	Date		Examiner
nventor Name Search: PALM, Google Scholar, IEEE	06/01/2006	MCJ	
Assignee Name Search: EAST, Google Scholar	06/01/2006	MCJ	
702/117,123; 703/15 (see search history)	06/01/2006	MCJ	
EAST Search: (see search history) (('test bench' <in>metadata) <and> (generate<in>metadata))<and> (hdl <or> 'hardware description language'<in>metadata)</in></or></and></in></and></in>			
EEE, ACM: test bench, generate, hardware description language, Virtual Intellectual Property Library	6/5/06	MCJ	
Google Scholar: Virtual Intellectual Property Library	6/5/06	MCJ	
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703	15	6/6/06	MCJ
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